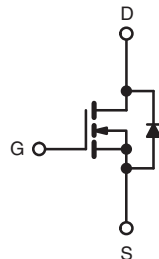
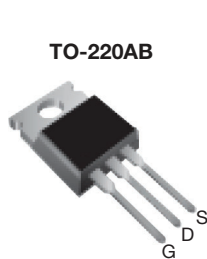


## Power MOSFET

| PRODUCT SUMMARY           |                  |      |
|---------------------------|------------------|------|
| $V_{DS}$ (V)              | 60               |      |
| $R_{DS(on)}$ ( $\Omega$ ) | $V_{GS} = 5.0$ V | 0.20 |
| $Q_g$ (Max.) (nC)         | 8.4              |      |
| $Q_{gs}$ (nC)             | 3.5              |      |
| $Q_{gd}$ (nC)             | 6.0              |      |
| Configuration             | Single           |      |



N-Channel MOSFET

### FEATURES

- Dynamic  $dV/dt$  Rating
- Logic-Level Gate Drive
- $R_{DS(on)}$  Specified at  $V_{GS} = 4$  V and 5 V
- 175 °C Operating Temperature
- Fast Switching
- Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC


**RoHS\***  
COMPLIANT

### DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220AB package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220AB contribute to its wide acceptance throughout the industry.

| ORDERING INFORMATION |            |
|----------------------|------------|
| Package              | TO-220AB   |
| Lead (Pb)-free       | IRLZ14PbF  |
|                      | SiHLZ14-E3 |
| SnPb                 | IRLZ14     |
|                      | SiHLZ14    |

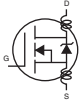
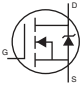
| ABSOLUTE MAXIMUM RATINGS ( $T_C = 25$ °C, unless otherwise noted) |                   |                  |      |
|---|-------------------|------------------|------|
| PARAMETER   | SYMBOL            | LIMIT            | UNIT |
| Drain-Source Voltage  | $V_{DS}$          | 60               | V    |
| Gate-Source Voltage   | $V_{GS}$          | $\pm 10$         |      |
| Continuous Drain Current  | $V_{GS}$ at 5.0 V | $T_C = 25$ °C    | 10   |
|   |                   | $T_C = 100$ °C   | 7.2  |
| Pulsed Drain Current <sup>a</sup>                                 | $I_{DM}$          | 40               | A    |
| Linear Derating Factor  |                   | 0.29             | W/°C |
| Single Pulse Avalanche Energy <sup>b</sup>                        | $E_{AS}$          | 39.5             | mJ   |
| Maximum Power Dissipation   | $T_C = 25$ °C     | $P_D$            | 43   |
| Peak Diode Recovery $dV/dt^c$                                     |                   | $dV/dt$          | 4.5  |
| Operating Junction and Storage Temperature Range                  | $T_J, T_{stg}$    | - 55 to + 175    | °C   |
| Soldering Recommendations (Peak Temperature)                      | for 10 s          | 300 <sup>d</sup> |      |
| Mounting Torque   | 6-32 or M3 screw  |                  | 10   |
|   |                   |                  | 1.1  |

#### Notes

- Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- $V_{DD} = 25$  V, starting  $T_J = 25$  °C,  $L = 0.79$  mH,  $R_g = 25$   $\Omega$ ,  $I_{AS} = 10$  A (see fig. 12).
- $I_{SD} \leq 10$  A,  $dI/dt \leq 90$  A/ $\mu$ s,  $V_{DD} \leq V_{DS}$ ,  $T_J \leq 175$  °C.
- 1.6 mm from case.

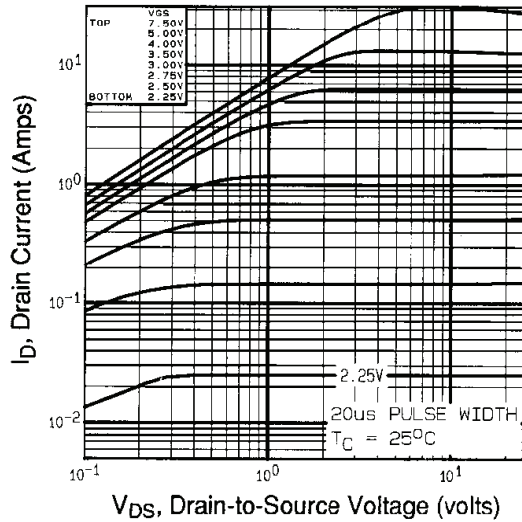
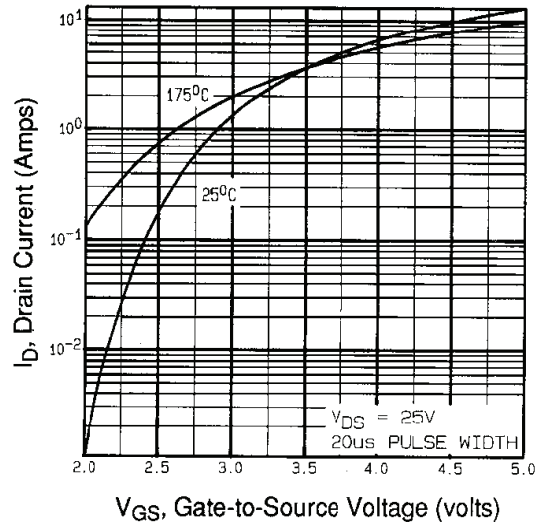
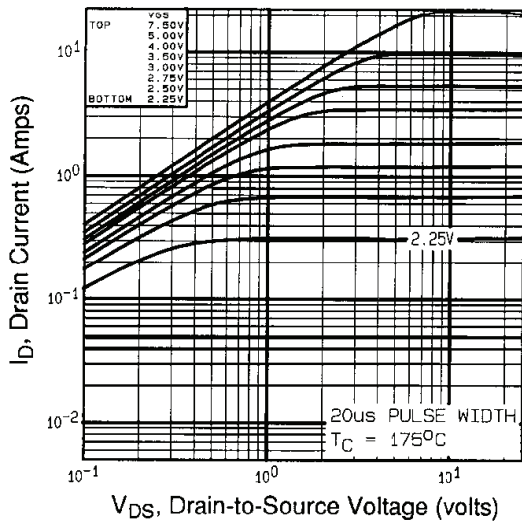
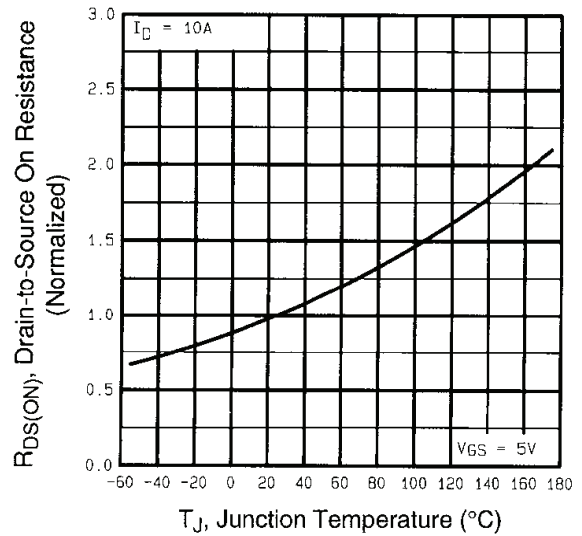
\* Pb containing terminations are not RoHS compliant, exemptions may apply

| THERMAL RESISTANCE                  |            |      |      |      |      |
|-------------------------------------|------------|------|------|------|------|
| PARAMETER                           | SYMBOL     | MIN. | TYP. | MAX. | UNIT |
| Maximum Junction-to-Ambient         | $R_{thJA}$ | -    | -    | 62   | °C/W |
| Case-to-Sink, Flat, Greased Surface | $R_{thCS}$ | -    | 0.50 | -    |      |
| Maximum Junction-to-Case (Drain)    | $R_{thJC}$ | -    | -    | 3.5  |      |

| SPECIFICATIONS ( $T_J = 25\text{ }^\circ\text{C}$ , unless otherwise noted) |                     |   |   |      |       |           |               |
|---|---------------------|---|---|------|-------|-----------|---------------|
| PARAMETER   | SYMBOL              | TEST CONDITIONS   |   | MIN. | TYP.  | MAX.      | UNIT          |
| <b>Static</b>   |                     |   |   |      |       |           |               |
| Drain-Source Breakdown Voltage  | $V_{DS}$            | $V_{GS} = 0\text{ V}, I_D = 250\text{ }\mu\text{A}$   |   | 60   | -     | -         | V             |
| $V_{DS}$ Temperature Coefficient  | $\Delta V_{DS}/T_J$ | Reference to $25\text{ }^\circ\text{C}$ , $I_D = 1\text{ mA}$   |   | -    | 0.070 | -         | V/°C          |
| Gate-Source Threshold Voltage   | $V_{GS(th)}$        | $V_{DS} = V_{GS}, I_D = 250\text{ }\mu\text{A}$   |   | 1.0  | -     | 2.0       | V             |
| Gate-Source Leakage   | $I_{GSS}$           | $V_{GS} = \pm 10\text{ V}$  |   | -    | -     | $\pm 100$ | nA            |
| Zero Gate Voltage Drain Current   | $I_{DSS}$           | $V_{DS} = 60\text{ V}, V_{GS} = 0\text{ V}$   |   | -    | -     | 25        | $\mu\text{A}$ |
|   |                     | $V_{DS} = 48\text{ V}, V_{GS} = 0\text{ V}, T_J = 150\text{ }^\circ\text{C}$  |   | -    | -     | 250       |               |
| Drain-Source On-State Resistance  | $R_{DS(on)}$        | $V_{GS} = 5.0\text{ V}$   | $I_D = 6.0\text{ A}^b$  | -    | -     | 0.20      | $\Omega$      |
|   |                     | $V_{GS} = 4.0\text{ V}$   | $I_D = 5.0\text{ A}^b$  | -    | -     | 0.28      |               |
| Forward Transconductance  | $g_{fs}$            | $V_{DS} = 25\text{ V}, I_D = 6.0\text{ A}^b$  |   | 3.5  | -     | -         | S             |
| <b>Dynamic</b>  |                     |   |   |      |       |           |               |
| Input Capacitance   | $C_{iss}$           | $V_{GS} = 0\text{ V}, V_{DS} = 25\text{ V}, f = 1.0\text{ MHz}$ , see fig. 5  |   | -    | 400   | -         | pF            |
| Output Capacitance  | $C_{oss}$           |   |   | -    | 170   | -         |               |
| Reverse Transfer Capacitance  | $C_{riss}$          |   |   | -    | 42    | -         |               |
| Total Gate Charge   | $Q_g$               | $V_{GS} = 5.0\text{ V}$   | $I_D = 10\text{ A}, V_{DS} = 48\text{ V}$<br>see fig. 6 and 13 <sup>b</sup> | -    | -     | 8.4       | nC            |
| Gate-Source Charge  | $Q_{gs}$            |   |   | -    | -     | 3.5       |               |
| Gate-Drain Charge   | $Q_{gd}$            |   |   | -    | -     | 6.0       |               |
| Turn-On Delay Time  | $t_{d(on)}$         | $V_{DD} = 30\text{ V}, I_D = 10\text{ A}$<br>$R_g = 12\text{ }\Omega, R_D = 2.8\text{ }\Omega$<br>see fig. 10 <sup>b</sup>                              |   | -    | 9.3   | -         | ns            |
| Rise Time   | $t_r$               |   |   | -    | 110   | -         |               |
| Turn-Off Delay Time   | $t_{d(off)}$        |   |   | -    | 17    | -         |               |
| Fall Time   | $t_f$               |   |   | -    | 26    | -         |               |
| Internal Drain Inductance   | $L_D$               | Between lead, 6 mm (0.25") from package and center of die contact  |   | -    | 4.5   | -         | nH            |
| Internal Source Inductance  | $L_S$               |   |   | -    | 7.5   | -         |               |
| <b>Drain-Source Body Diode Characteristics</b>                              |                     |   |   |      |       |           |               |
| Continuous Source-Drain Diode Current                                       | $I_S$               | MOSFET symbol showing the integral reverse p - n junction diode    |   | -    | -     | 10        | A             |
| Pulsed Diode Forward Current <sup>a</sup>                                   | $I_{SM}$            |   |   | -    | -     | 40        |               |
| Body Diode Voltage  | $V_{SD}$            | $T_J = 25\text{ }^\circ\text{C}, I_S = 10\text{ A}, V_{GS} = 0\text{ V}^b$  |   | -    | -     | 1.6       | V             |
| Body Diode Reverse Recovery Time  | $t_{rr}$            | $T_J = 25\text{ }^\circ\text{C}, I_F = 10\text{ A}, di/dt = 100\text{ A}/\mu\text{s}^b$   |   | -    | 93    | 130       | ns            |
| Body Diode Reverse Recovery Charge  | $Q_{rr}$            |   |   | -    | 0.34  | 0.65      |               |
| Forward Turn-On Time  | $t_{on}$            | Intrinsic turn-on time is negligible (turn-on is dominated by $L_S$ and $L_D$ )   |   |      |       |           |               |

**Notes**

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width  $\leq 300\text{ }\mu\text{s}$ ; duty cycle  $\leq 2\%$ .

**TYPICAL CHARACTERISTICS** (25 °C, unless otherwise noted)

**Fig. 1 - Typical Output Characteristics,  $T_C = 25\text{ }^\circ\text{C}$** 

**Fig. 3 - Typical Transfer Characteristics**

**Fig. 2 - Typical Output Characteristics,  $T_C = 175\text{ }^\circ\text{C}$** 

**Fig. 4 - Normalized On-Resistance vs. Temperature**

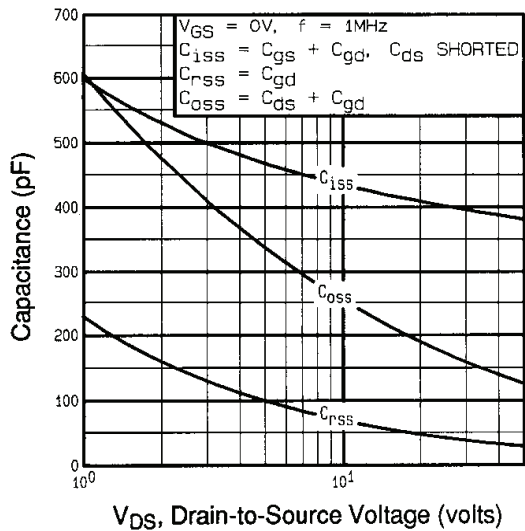


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

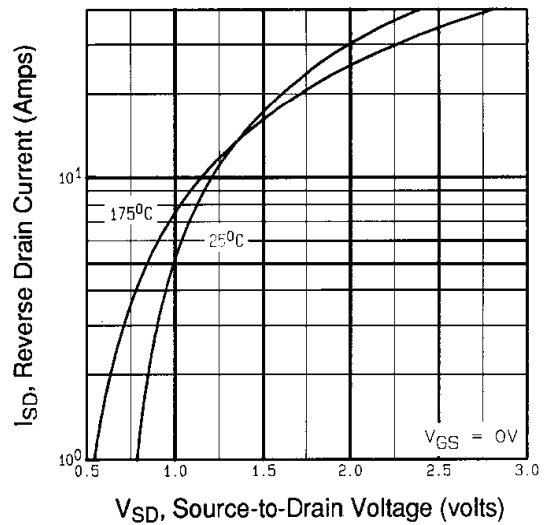


Fig. 7 - Typical Source-Drain Diode Forward Voltage

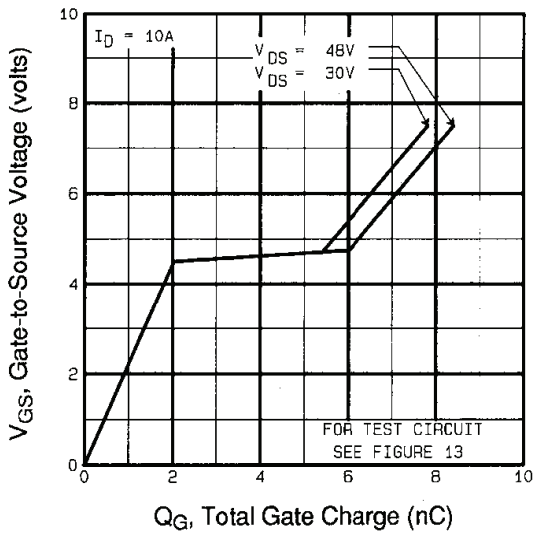


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

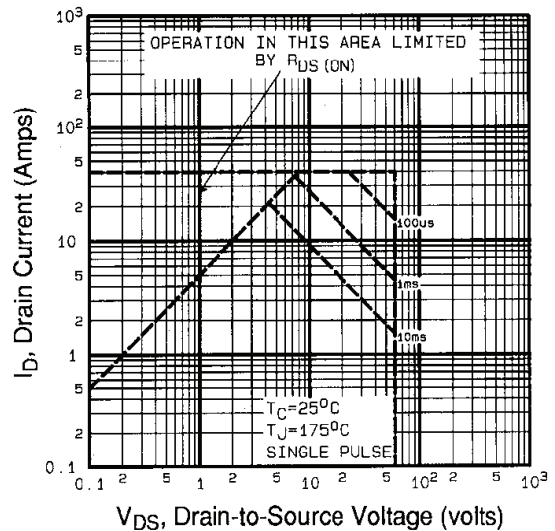


Fig. 8 - Maximum Safe Operating Area

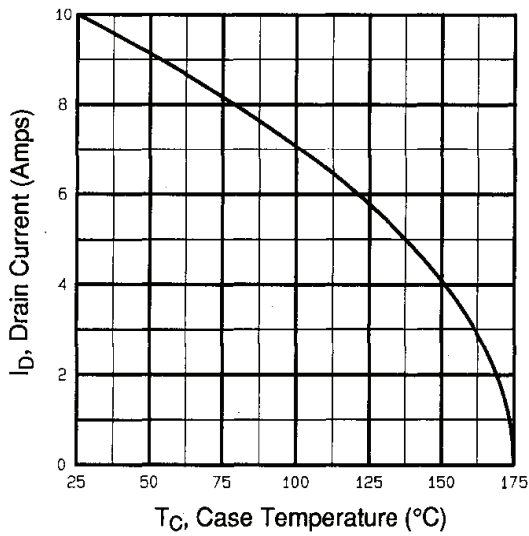


Fig. 9 - Maximum Drain Current vs. Case Temperature

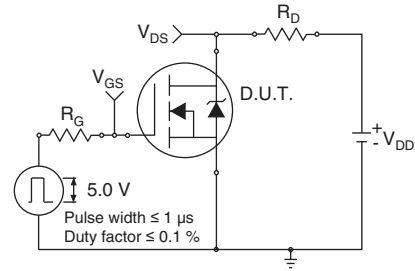


Fig. 10a - Switching Time Test Circuit

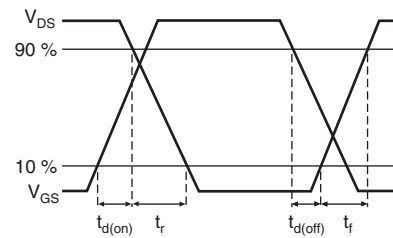


Fig. 10b - Switching Time Waveforms

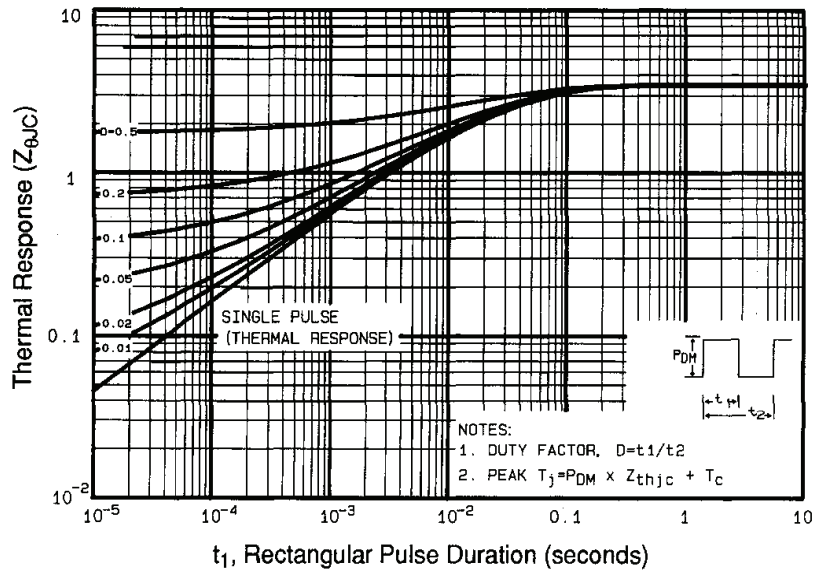


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

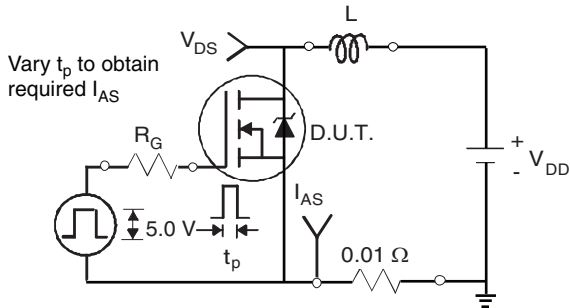


Fig. 12a - Unclamped Inductive Test Circuit

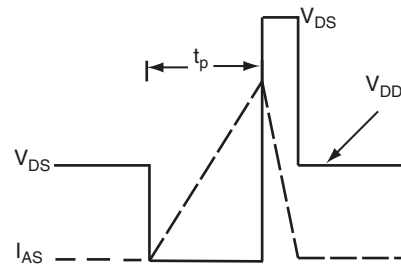


Fig. 12b - Unclamped Inductive Waveforms

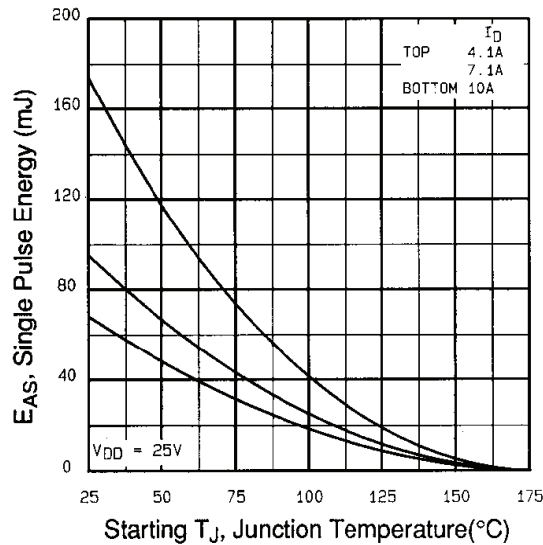


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

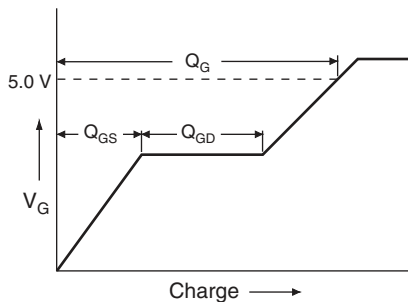


Fig. 13a - Basic Gate Charge Waveform

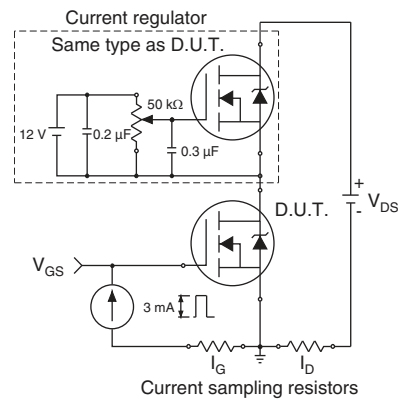
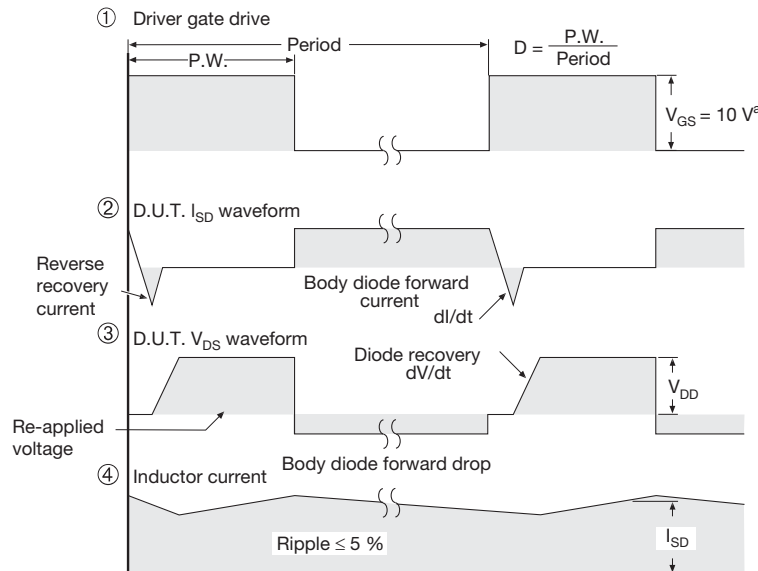
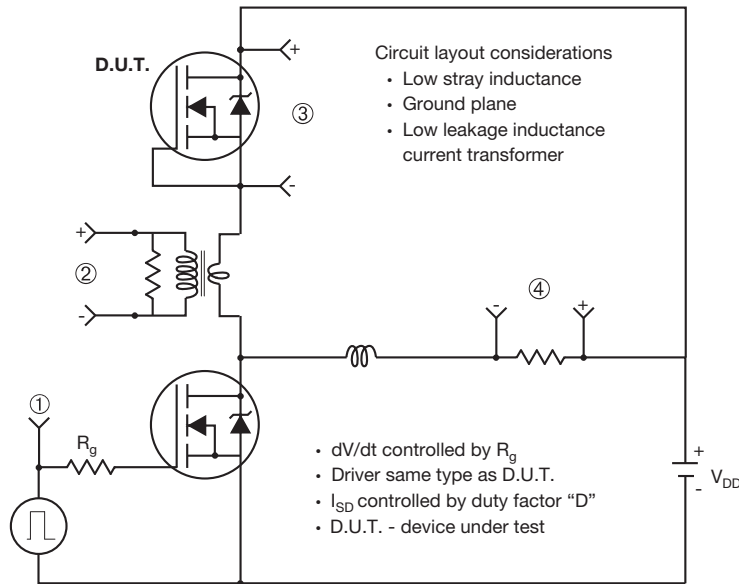


Fig. 13b - Gate Charge Test Circuit

### Peak Diode Recovery dV/dt Test Circuit



**Note**

a.  $V_{GS} = 5\text{ V}$  for logic level devices

**Fig. 14 - For N-Channel**

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